

INTERNATIONAL ELECTROTECHNICAL COMMISSION  
COMMISSION ÉLECTROTECHNIQUE INTERNATIONALE

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**IEC 61000-4-11**  
Edition 3.0 2020-01

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**ELECTROMAGNETIC COMPATIBILITY (EMC) –**

**Part 4-11: Testing and measurement techniques – Voltage dips, short interruptions and voltage variations immunity tests for equipment with input current up to 16 A per phase**

**COMPATIBILITE ELECTROMAGNETIQUE (CEM) –**

**Partie 4-11: Techniques d'essai et de mesure – Essais d'immunité aux creux de tension, coupures brèves et variations de tension pour les appareils à courant d'entrée inférieur ou égal à 16 A par phase**

## **CORRIGENDUM 2**

Corrections to the French version appear after the English text.

Les corrections à la version française sont données après le texte anglais.

### **5.3 Voltage variations (optional)**

*Replace the heading, as modified by Corrigendum 1, with the following new heading:*

### **5.3 Voltage variations**

## **7 Test set-up**

*Replace the second paragraph with the following new paragraph:*

The test set-ups are defined for the three types of phenomena described in this document.

## **9 Evaluation of test results**

*Replace the note with the following new note:*

**NOTE** The performance levels can be different for voltage dip tests and short interruption tests as well as for voltage variations tests.